onsemi

Half-Bridge Gate Driver

FAN7380

Description

The FAN7380 is a monolithic half-bridge gate-drive IC for MOSFETs and IGBTs that operate up to +600 V. **onsemi**'s high-voltage process and common-mode noise cancelling technique provide stable operation of high-side driver under high-dv/dt noise circumstances. An advanced level-shift circuit allows high-side gate driver operation up to $V_S = -9.8$ V (typical) for $V_{BS} = 15$ V. The input logic level is compatible with standard TTL-series logic gates. The internal shoot-through protection circuit provides 100 ns dead-time to prevent output switching devices from both conducting during transition periods. UVLO circuits for both channels prevent malfunction when V_{CC} and V_{BS} are lower than the specified threshold voltage. Output drivers typically source / sink at 90 mA / 180 mA, respectively, which is suitable for fluorescent / compact fluorescent lamp ballast applications and systems requiring low di/dt noise.

Features

- Floating Channel Designed for Bootstrapping Operation to +600 V
- Typically 90 mA / 180 mA Sourcing/Sinking Current Driving Capability for Both Channels
- Common-Mode dv/dt Noise Cancelling Circuit
- Extended Allowable Negative V_S Swing to -9.8 V for Signal Propagation at V_{CC} = V_{BS} = 15 V
- V_{CC} & V_{BS} Supply Range from 10 V to 20 V
- UVLO Functions for Both Channels
- TTL–Compatible Input Logic Threshold Levels
- Matched Propagation Delay Below 50 ns
- Built–in 100 ns Dead–Time Control Function
- Output In–Phase with Input Signal
- This is a Pb–Free Device

Typical Applications

- Fluorescent Lamp Ballast
- Compact Fluorescent Lamp Ballast

Related Resources

- https://www.onsemi.com/pub/collateral/an-6076.pdf
- https://www.onsemi.com/pub/collateral/an-9052.pdf
- https://www.onsemi.com/pub/collateral/an-8102.pdf



(8-SOP) CASE 751EG



ORDERING INFORMATION

See detailed ordering and shipping information on page 11 of this data sheet.

TYPICAL APPLICATION CIRCUIT



Figure 1. Application Circuit for Fluorescent Lamp Ballast



INTERNAL BLOCK DIAGRAM

Figure 2. Functional Block Diagram

PIN CONFIGURATION



Figure 3. Pin Configuration (Top View)

PIN DEFINITIONS

Pin No.	Name	I/O	Description	
1	LIN	I	Logic Input for Low–Side Gate Driver Output	
2	HIN	I	Logic Input for High-Side Gate Driver Output	
3	V _{CC}	I	Low-Side Supply Voltage	
4	СОМ		Logic Ground and Low-Side Driver Return	
5	LO	0	Low–Side Driver Output	
6	VS	I	High–Voltage Floating Supply Return	
7	НО	0	High–Side Driver Output	
8	VB	I	High-Side Floating Supply	

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$, unless otherwise specified.)

Symbol	Parameter	Min	Мах	Unit
VS	High-side Offset Voltage	V _B – 25	V _B + 0.3	V
VB	High-side Floating Supply Voltage	-0.3	625.0	
V _{HO}	High-side Floating Output Voltage HO	V _S – 0.3	V _B + 0.3	
V _{CC}	Low-side and Logic-fixed Supply Voltage	-0.3	25.0	
V _{LO}	Low-side Output Voltage LO	-0.3	V _{CC} + 0.3	
V _{IN}	Logic Input Voltage (HIN, LIN)	-0.3	V _{CC} + 0.3	
COM	Logic Ground	V _{CC} – 25	V _{CC} + 0.3	
dV _S /dt	Allowable Offset Voltage Slew Rate	-	50	V/ns
P _D (Note 1, 2, 3)	Power Dissipation	-	0.625	W
θ_{JA}	Thermal Resistance, Junction-to-ambient	-	200	°C/W
TJ	Junction Temperature	-	150	°C
Τ _S	Storage Temperature	-50	150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Mounted on 76.2 x 114.3 x 1.6 mm PCB (FR-4 glass epoxy material).

Refer to the following standards: JESD51–2: Integral circuits thermal test method environmental conditions – natural convection

JESD51-3: Low effective thermal conductivity test board for leaded surface mount packages

3. Do not exceed P_D under any circumstances.

RECOMMENDED OPERATING RATINGS

Symbol	Parameter	Min	Мах	Unit
VB	High-side Floating Supply Voltage	V _S + 10	V _S + 20	V
VS	High-side Floating Supply Offset Voltage	6 – V _{CC}	600	
V _{HO}	High-side (HO) Output Voltage	VS	VB	
V _{LO}	Low-side (LO) Output Voltage	СОМ	V _{CC}	
V _{IN}	Logic Input Voltage (HIN, LIN)	СОМ	V _{CC}	
V _{CC}	Low-side Supply Voltage	10	20	
T _A	Ambient Temperature	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

STATIC ELECTRICAL CHARACTERISTICS (V _{BIAS} (V _{CC} , V _{BS}) = 15.0 V, T _A = 25°C, unless otherwise specified. The V _{IN} and I _{IN}
parameters are referenced to COM. The V _O and I _O parameters are referenced to V _S and COM and are applicable to the respective
outputs HO and LO.)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V _{CCUV} + V _{BSUV} +	V _{CC} & V _{BS} Supply Under–voltage Positive Going Threshold		8.2	9.2	10.0	V
V _{CCUV} - V _{BSUV} -	V _{CC} & V _{BS} Supply Under–voltage Negative Going Threshold		7.6	8.7	9.6	
V _{CCUVH} V _{BSUVH}	V _{CC} Supply Under-voltage Lockout Hysteresis		-	0.5	-	
I _{LK}	Offset Supply Leakage Current	$V_{B} = V_{S} = 600 \text{ V}$	-	-	50	μΑ
I _{QBS}	Quiescent V _{BS} Supply Current	V _{IN} = 0 V or 5 V	-	44	100	
IQCC	Quiescent V _{CC} Supply Current	V _{IN} = 0 V or 5 V	-	70	180	
I _{PBS}	Operating V _{BS} Supply Current	f _{IN} = 20 kHz, rms value	-	-	600	μΑ
I _{PCC}	Operating V _{CC} Supply Current	f _{IN} = 20 kHz, rms value	-	-	610	
V _{IH}	Logic "1" Input Voltage		2.5	-	-	V
VIL	Logic "0" Input Voltage		-	-	0.8	
V _{OH}	High-level Output Voltage, $V_{BIAS}-V_O$	I _O = 20 mA	-	-	2.8	V
V _{OL}	Low-level Output Voltage, V _O		-	-	1.2	
I _{IN+}	Logic "1" Input Bias Current	V _{IN} = 5 V	-	5	40	μΑ
I _{IN-}	Logic "0" Input Bias Current	V _{IN} = 0 V	-	1.0	2.0	
I _{O+}	Output HIGH Short-circuit Pulse Current	V_{O} = 0 V, V_{IN} = 5 V with PW \leq 10 μs	60	90	_	mA
I _{O-}	Output LOW Short-circuit Pulsed Current	V_O = 15 V, V_{IN} = 0 V with PW \leq 10 μs	130	180	-	
V _S	Allowable Negative V _S Pin Voltage for HIN Signal Propagation to HO		-	-9.8	-7.0	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

DYNAMIC ELECTRICAL CHARACTERISTICS (V_{BIAS} (V_{CC} , V_{BS}) = 15.0 V, V_S = COM, C_L = 1000 pF and T_A = 25°C, unless otherwise specified.)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
t _{on}	Turn-on Propagation Delay	$V_{\rm S} = 0 \ V$	70	135	200	ns
t _{off}	Turn-off Propagation Delay	V _S = 0 V or 600 V (Note 4)	60	130	190	
tr	Turn-on Rise Time		160	230	290	
t _f	Turn-off Fall Time		20	90	160	
DT	Dead Time		80	120	190	
MT	Delay Matching, HS & LS Turn-on/off		_	-	50	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. This parameter guaranteed by design.

TYPICAL PERFORMANCE CHARACTERISTICS











Figure 8. Turn-On Rising Time vs. Supply Voltage



Figure 5. Turn–On Propagation Delay vs. Temperature



Figure 7. Turn–Off Propagation Delay vs. Temperature



Figure 9. Turn–On Rising Time vs. Temperature



Figure 10. Turn-Off Falling Time vs. Supply Voltage



Figure 12. Dead-Time vs. Supply Voltage



Figure 14. Output Sourcing Current vs. Supply Voltage



Figure 11. Turn–Off Falling Time vs. Temperature



Figure 13. Dead–Time vs. Temperature



Figure 15. Output Sourcing Current vs. Temperature











Figure 20. I_{QCC} vs. Supply Voltage



Figure 17. Output Sinking Current vs. Temperature







Figure 21. I_{QCC} vs. Temperature







Figure 24. High–Level Output Voltage vs. Supply Voltage



Figure 26. Low–Level Output Voltage vs. Supply Voltage



Figure 23. IQBS vs. Temperature



Figure 25. High–Level Output Voltage vs. Temperature



Figure 27. Low–Level Output Voltage vs. Temperature



Figure 28. Input Bias Current vs. Supply Voltage



Figure 30. V_{CC} UVLO Threshold Voltage vs. Temperature



Figure 32. VB to COM Leakage Current vs. Temperature



Figure 29. Input Bias Current vs. Temperature



Figure 31. V_{BS} UVLO Threshold Voltage vs. Temperature



Figure 33. Input Logic Threshold vs. Temperature

SWITCHING TIME DEFINITIONS



Figure 34. Switching Time Waveforms



Figure 35. Internal Dead-Time Timing

ORDERING INFORMATION

Device	Package	Operating Temperature	Description	Shipping [†]
FAN7380MX (Note 5)	SOIC8 (8–SOP) (Pb–Free)	–40°C~+125°C	Lightning Application	3000 / Tape & Reel

5. This device has passed wave soldering test by JESD22A-111.

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



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